

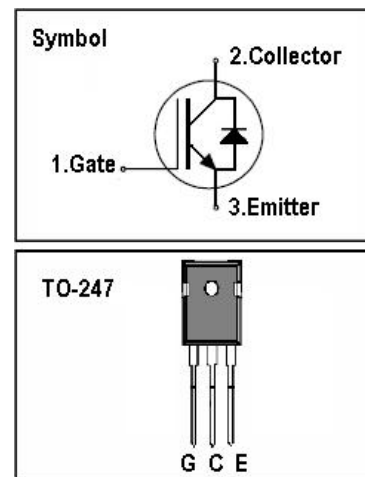
IGBT

Features

- 1200V, 15A
- $V_{CE(sat)(typ.)}=2.2V@V_{GE}=15V, I_C=15A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA using NPT technology

General Description

KEDA NPT IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating), UPS, general inverter and other soft switching applications.



Absolute Maximum Ratings

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 30	V
I_C	Continuous Collector Current ($T_C=25^\circ C$)	30	A
	Continuous Collector Current ($T_C=100^\circ C$)	15	A
I_{CM}	Pulsed Collector Current (Note 1)	60	A
I_F	Diode Continuous Forward Current ($T_C=100^\circ C$)	15	A
I_{FM}	Diode Maximum Forward Current (Note 1)	60	A
t_{sc}	Short Circuit Withstand Time	10	us
P_D	Maximum Power Dissipation ($T_C=25^\circ C$)	170	W
	Maximum Power Dissipation ($T_C=100^\circ C$)	68	W
T_J	Operating Junction Temperature Range	-55 to +150	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Max.	Units
$R_{th j-c}$	Thermal Resistance, Junction to case for IGBT	0.51	$^\circ C / W$
$R_{th j-c}$	Thermal Resistance, Junction to case for Diode	0.85	$^\circ C / W$
$R_{th j-a}$	Thermal Resistance, Junction to Ambient	40	$^\circ C / W$

Electrical Characteristics (T_C=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250uA	1200	-	-	V
I _{CES}	Collector-Emitter Leakage Current	V _{CE} = 1200V, V _{GE} = 0V	-	-	250	uA
I _{GES}	Gate Leakage Current, Forward	V _{GE} =30V, V _{CE} = 0V	-	-	100	nA
	Gate Leakage Current, Reverse	V _{GE} = -30V, V _{CE} = 0V	-	-	-100	nA
V _{GE(th)}	Gate Threshold Voltage	V _{GE} = V _{CE} , I _C = 250uA	4.5	-	5.5	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} =15V, I _C = 15A	-	2.2		V
Q _g	Total Gate Charge	V _{CC} =960V V _{GE} =15V I _C =15A	-	68		nC
Q _{ge}	Gate-Emitter Charge		-	22		nC
Q _{gc}	Gate-Collector Charge		-	23		nC
t _{d(on)}	Turn-on Delay Time	V _{CC} =600V V _{GE} =15V I _C =15A R _G =28Ω Inductive Load T _C =25 °C	-	32	-	ns
t _r	Turn-on Rise Time		-	38	-	ns
t _{d(off)}	Turn-off Delay Time		-	223	-	ns
t _f	Turn-off Fall Time		-	74	-	ns
E _{on}	Turn-on Switching Loss		-	1.6	-	mJ
E _{off}	Turn-off Switching Loss		-	0.6	-	mJ
E _{ts}	Total Switching Loss		-	2.2	-	mJ
C _{ies}	Input Capacitance	V _{CE} =25V V _{GE} =0V f = 100kHz	-	481	-	pF
C _{oes}	Output Capacitance		-	89	-	pF
C _{res}	Reverse Transfer Capacitance		-	28	-	pF
R _{Gint}	Integrated gate resistor			3.8		Ω

Electrical Characteristics of Diode (T_C=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _F	Diode Forward Voltage	I _F =15A	-	2.0	2.4	V
t _{rr}	Diode Reverse Recovery Time	V _{CE} = 600V I _F = 15A dI _F /dt = 500A/us	-	110		ns
I _{rr}	Diode peak Reverse Recovery Current		-	16		A
Q _{rr}	Diode Reverse Recovery Charge		-	1060		nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

Typical Performance Characteristics

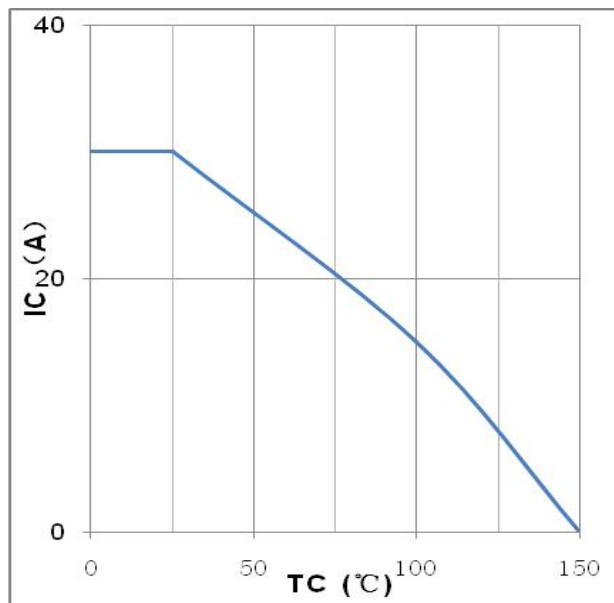


Figure1:maximum DC collector current
VS. case temperature

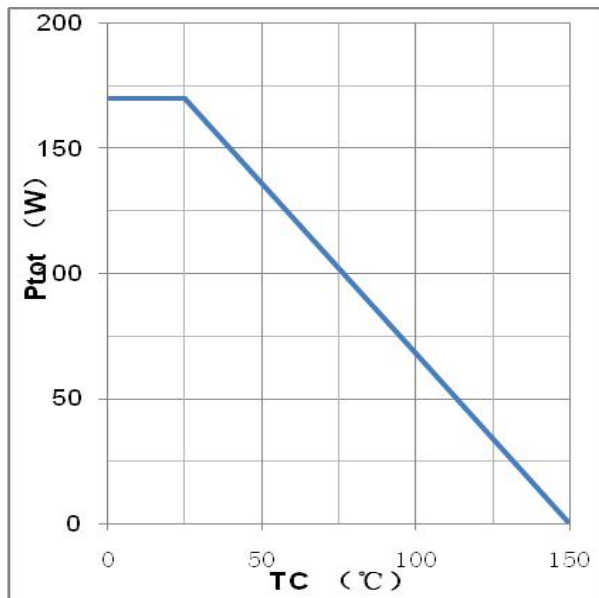


Figure2:power dissipation VS. case temperature

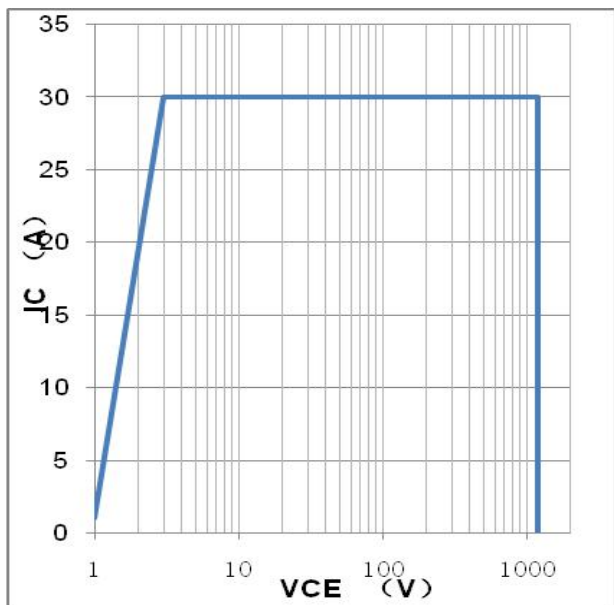


Figure3:reverse bias SOA, $T_J=150^{\circ}C$, $V_{GE}=15V$

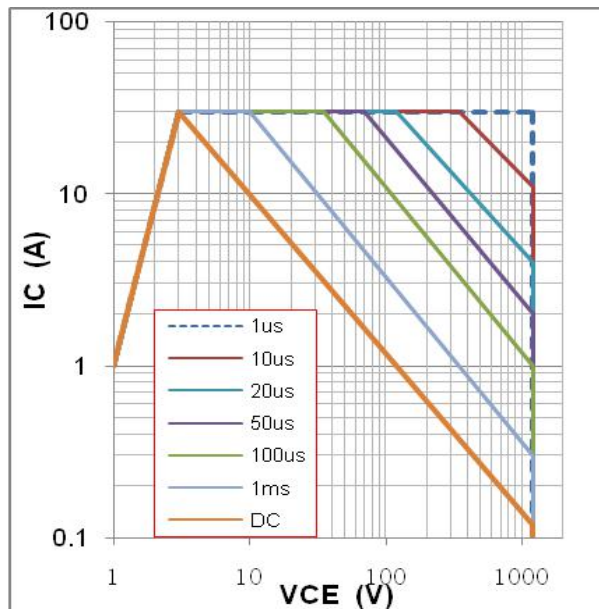


Figure4:forward SOA, $T_C=25^{\circ}C$, $T_J \leq 150^{\circ}C$

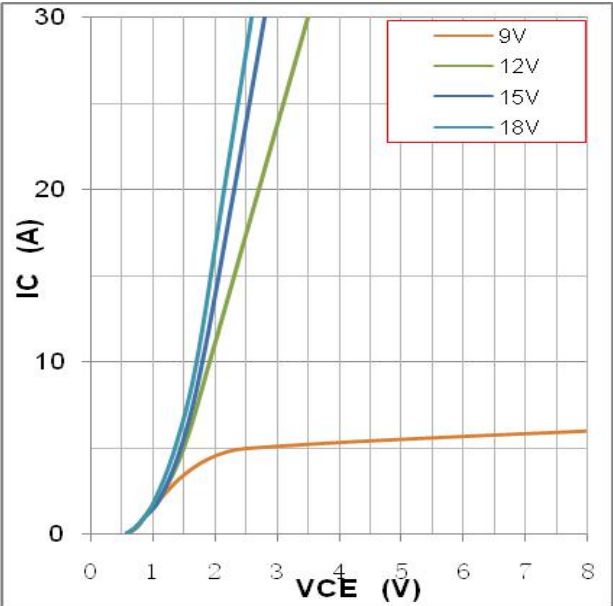


Figure5: typical IGBT output characteristics,
 $T_J=25^{\circ}\text{C}$; $t_p=300\mu\text{s}$

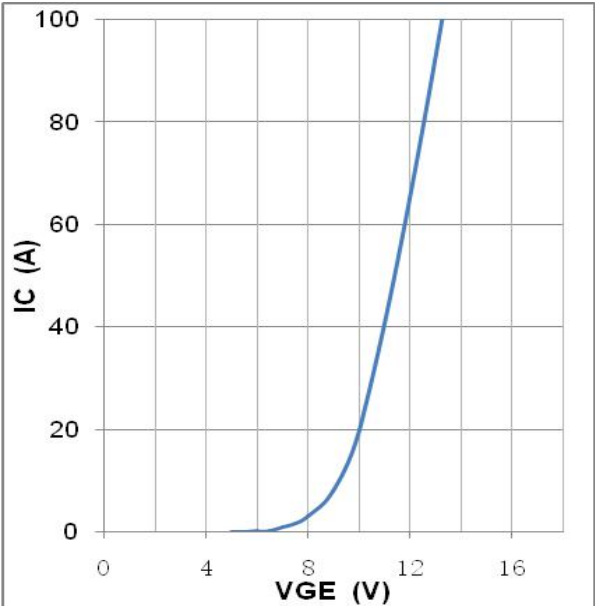


Figure6: typical trans characteristics, $V_{CE}=20\text{V}$, $t_p=20\mu\text{s}$

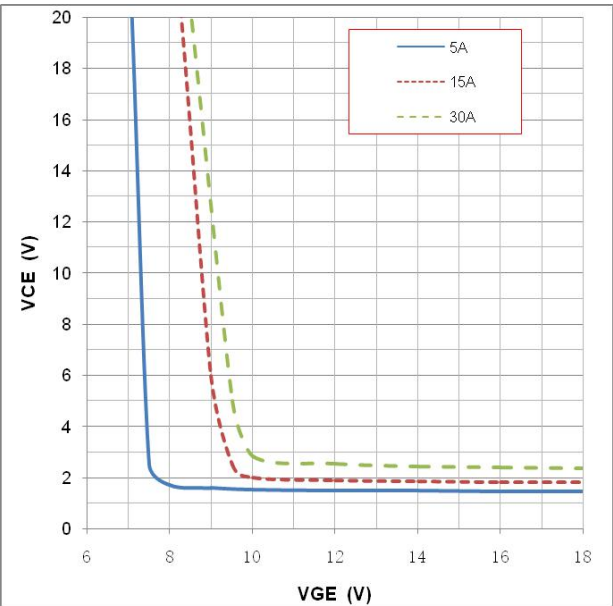


Figure7: typical V_{CE} VS. V_{GE} , $T_J=25^{\circ}\text{C}$

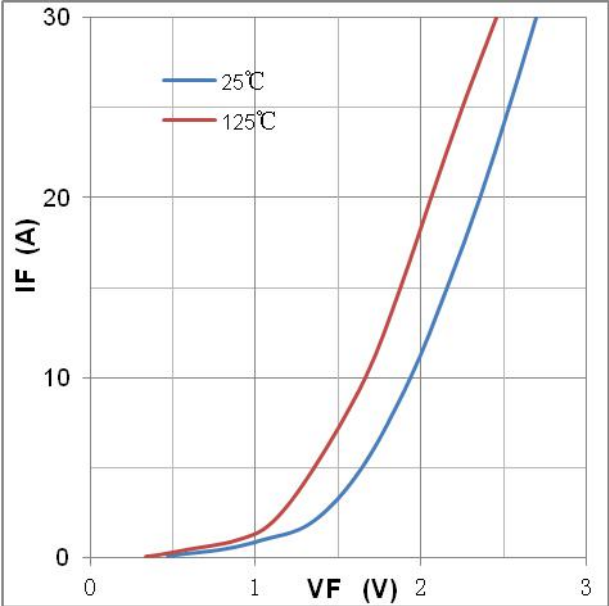


Figure8: typical diode forward characteristic, $t_p=300\mu\text{s}$

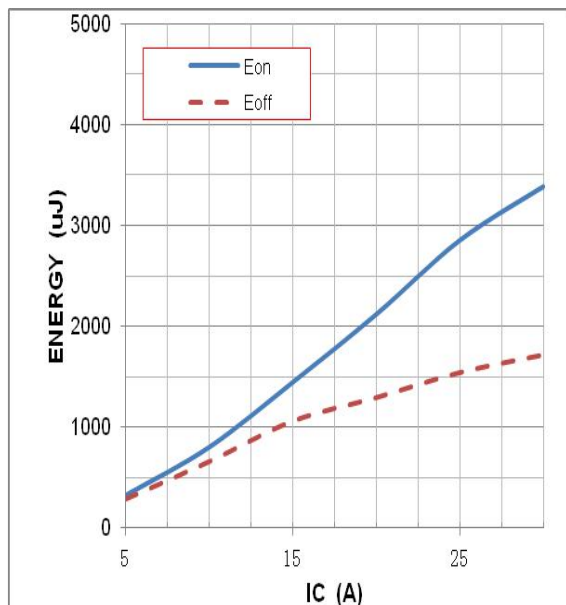


Figure9: typical energy loss VS. IC, TC=25°C,
L=500uH, VCE=600V, VGE=15V, Rg=28Ω,

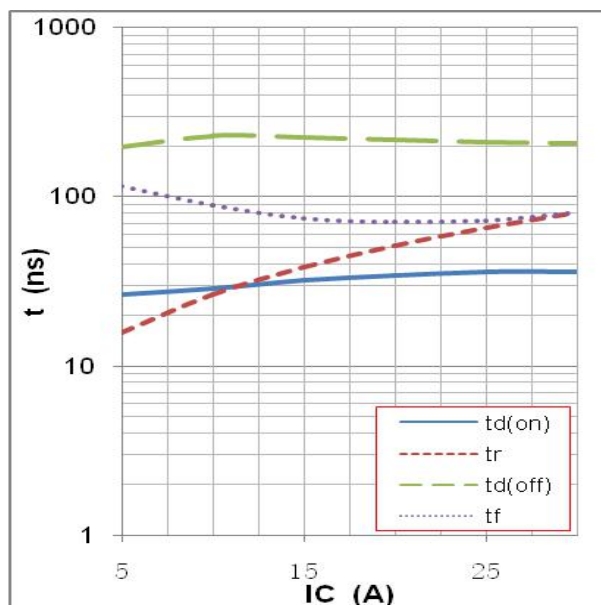


Figure10: typical switching time VS. IC, TC=25°C,
L=500uH, VCE=600V, VGE=15V, Rg=28Ω,

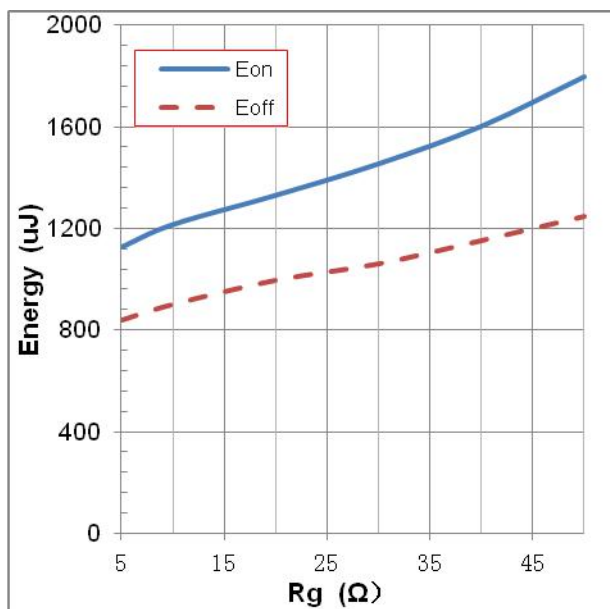


Figure11: typical energy loss VS. Rg, TC=25°C,
L=500uH, VCE=600V, VGE=15V, IC=15A

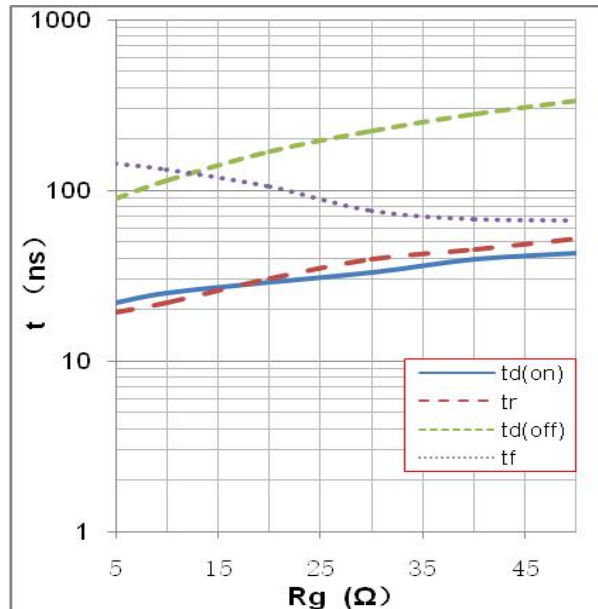


Figure12: typical switching time VS. Rg, TC=25°C,
L=500uH, VCE=600V, VGE=15V, IC=15A

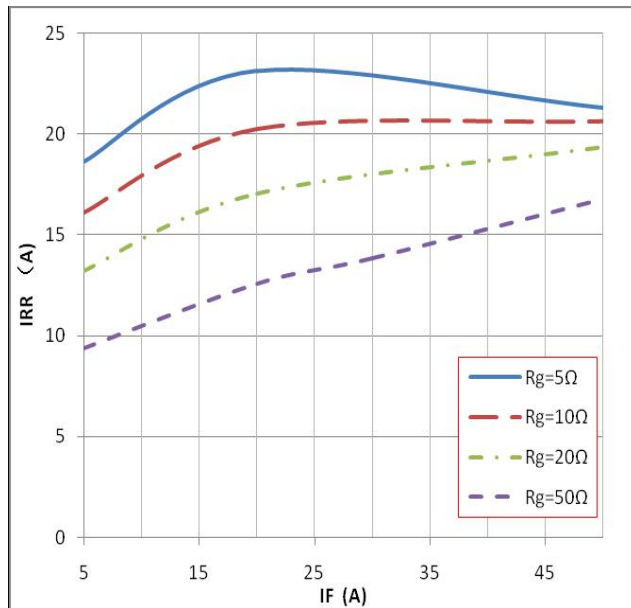


Figure13: typical diode IRR VS. IF, TC=25°C

VCC=600V, VGE=15V

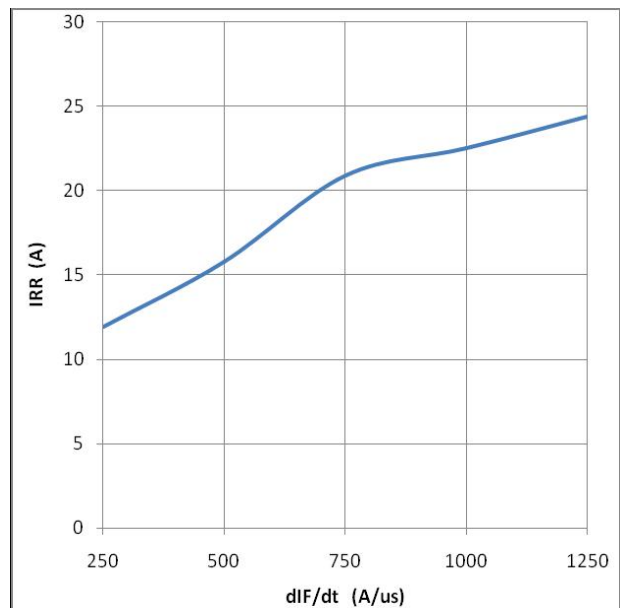


Figure14: typical diode IRR VS. dIF/dt

VCC=600V, VGE=15V IF=15A

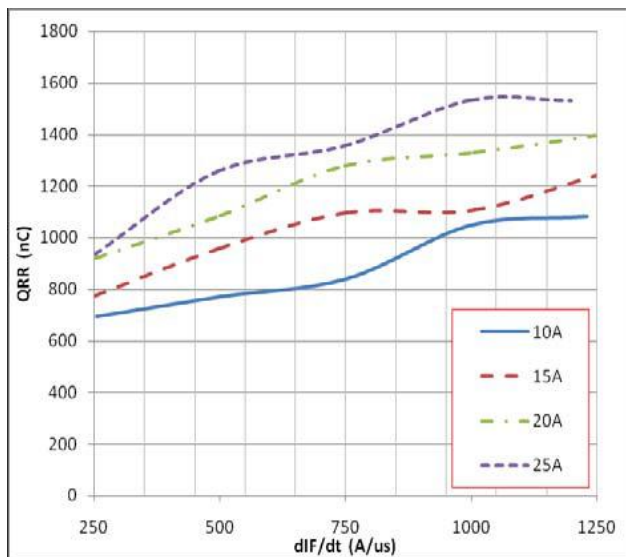


Figure15: typical diode QRR VS. dIF/dt

VCC=600V, VGE=15V

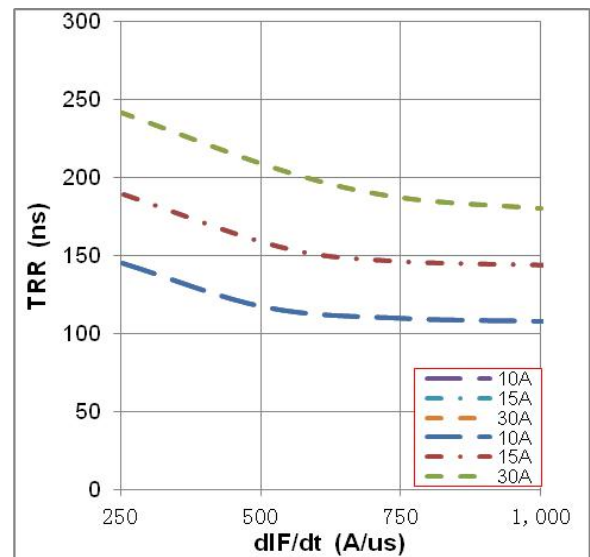


Figure16: typical diode TRR VS. dIF/dt,

VCC=600V, VGE=15V

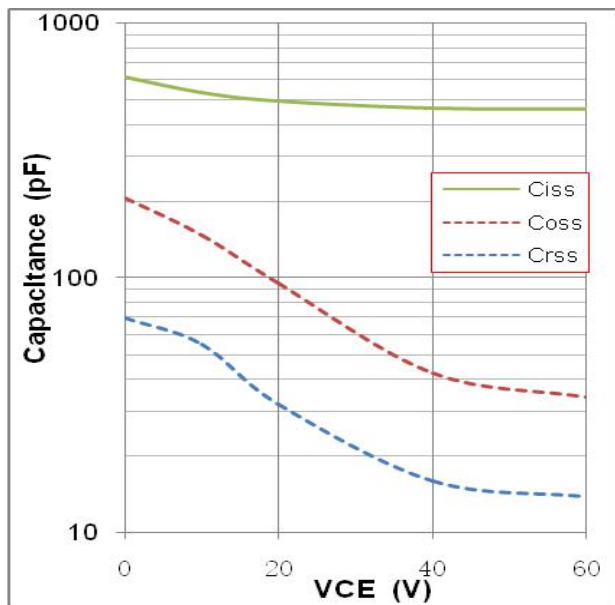


Figure17:typical capacitance VS. VCE,VGE=0V,f=100kHz

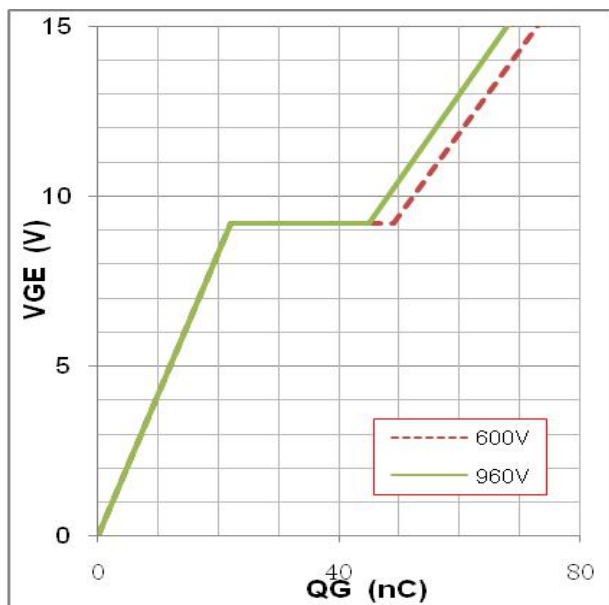


Figure18:typical gate charge VS. VGE,IC=15A

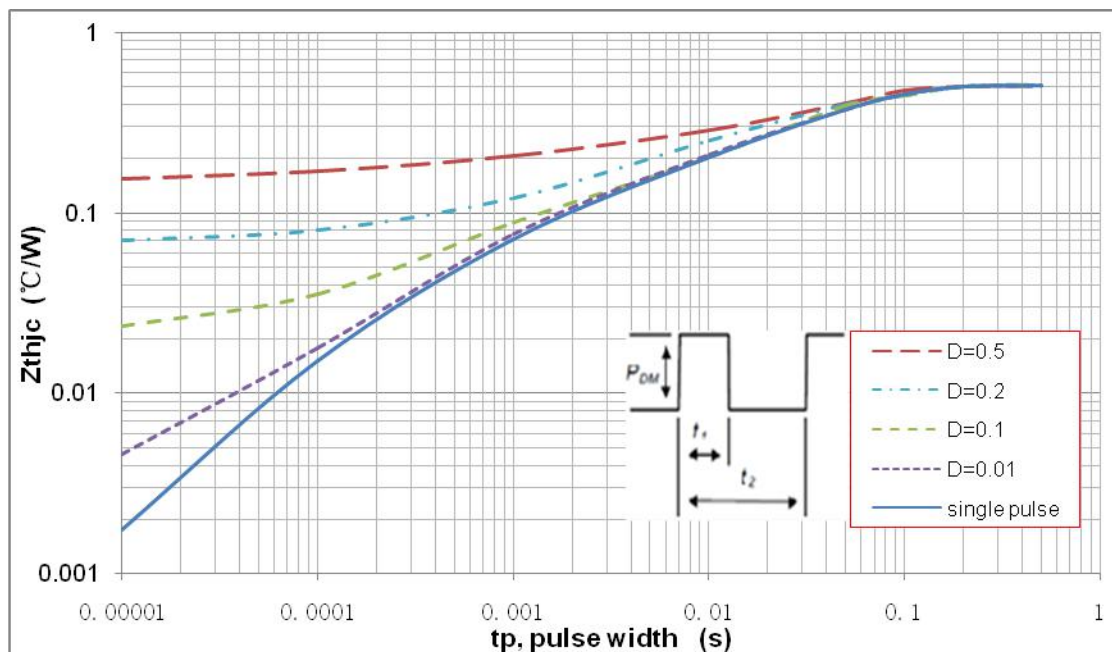
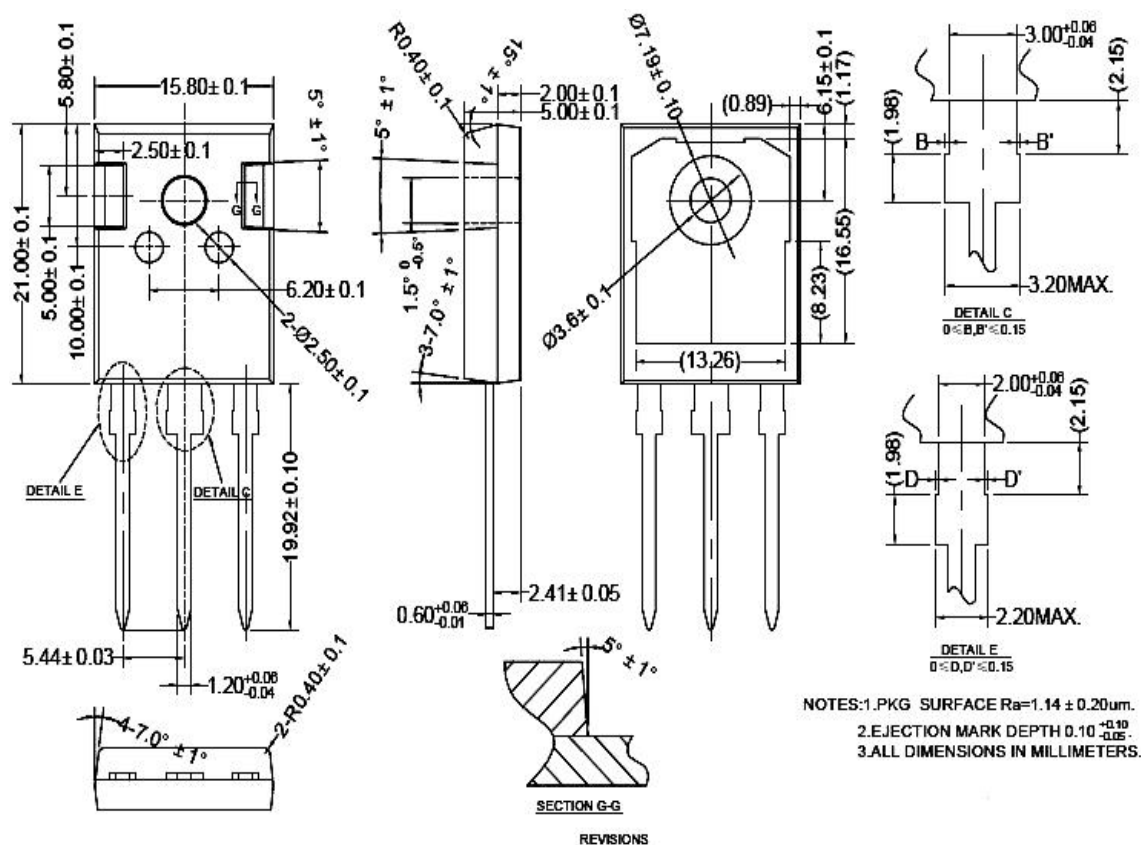


Figure19:normalised transient thermal impedance, junction-to-case

Note1.Duty factor $D=t_1/t_2$;

Note2:peak $T_J=P_{DM} \times Z_{thjc} + T_C$

TO247 PACKAGE OUTLINE



公差标注	公差值	表面粗糙度
0	± 0.2	Ra3.2~6.3
0.0	± 0.1	Ra1.6~3.2
0.00	± 0.01	Ra0.8~1.6
0.000	± 0.005	Ra0.4~0.8
0.0000	± 0.002	Ra0.2~0.4

 $0 \leq D, D' \leq 0.15$

NOTES:1.PKG SURFACE Ra=1.14 ± 0.20um.
2.EJECTION MARK DEPTH 0.10 ^{+0.10}_{-0.05}.
3.ALL DIMENSIONS IN MILLIMETERS.